



<p><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10747790</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>FEHR, WALTON</p>
	<p>Examiner</p> <p>Kaplan, Hal I</p>	<p>Art Unit</p> <p>2836</p>

Class	SubClass	Date	Examiner
307	9.1	05/24/2006	HK

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<b>Search Notes</b>  	Application/Control No.  10747790	Applicant(s)/Patent Under Reexamination  FEHR, WALTON
	Examiner Kaplan, Hal I	Art Unit 2836

Notes	Date	Examiner
307/23,29,80,82 (consulted Robert DeBeradinis)	05/25/2006	HK
710/\$ (no search), 713/323,324 (consulted Fritz Fleming)	05/25/2006	HK
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB)	5/24/06	HK
EAST (US-PGPUB,USPAT,USOCR,EPO,JPO,DERWENT,IBM_TDB)	5/25/06	HK
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